

<b>Notice of References Cited</b>	Application/Control No. 10/765,876	Applicant(s)/Patent Under Reexamination LEE, TAE-HEE	
	Examiner ASHER KHAN	Art Unit 4134	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0001704 A1	01-2004	Chan et al.	386/96
	B	US-			
	C	US-			
	D	US-			
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**FOREIGN PATENT DOCUMENTS**

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